

FDZ206P

P-Channel 2.5V Specified PowerTrench® BGA MOSFET

General Description

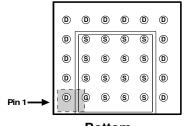
Combining Fairchild's advanced 2.5V specified PowerTrench process with state of the art BGA packaging, the FDZ206P minimizes both PCB space and $R_{\text{DS(ON)}}$. This BGA MOSFET embodies a breakthrough in packaging technology which enables the device to combine excellent thermal transfer characteristics, high current handling capability, ultralow profile packaging, low gate charge, and low R_{DS(ON)}.

Applications

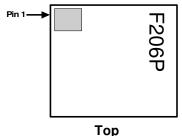
- · Battery management
- · Load switch
- · Battery protection

Features

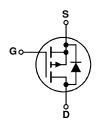
- -13 A, -20 V. $R_{DS(ON)} = 9.5 \text{ m}\Omega$ @ $V_{GS} = -4.5 \text{ V}$ $R_{DS(ON)} = 14.5 \text{ m}\Omega$ @ $V_{GS} = -2.5 \text{ V}$
- Occupies only 14 mm² of PCB area. Only 42% of the area of SO-8
- Ultra-thin package: less than 0.80 mm height when mounted to PCB
- 0.65 mm ball pitch
- 3.5 x 4 mm² footprint
- · High power and current handling capability











Absolute Maximum Ratings T_{A=25°C} unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		-20	V
V _{GSS}	Gate-Source Voltage		±12	V
I _D	Drain Current - Continuous	(Note 1a)	-13	A
	– Pulsed		–60	
P _D	Power Dissipation (Steady State)	(Note 1a)	2.2	W
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	56	°C/W
$R_{\theta JB}$	Thermal Resistance, Junction-to-Ball	(Note 1)	4.5	
$R_{ heta JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	0.6	

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
206P	FDZ206P	13"	12mm	3000

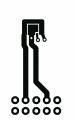
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{D} = -250 \mu\text{A}$	-20			V
<u>ΔBV_{DSS}</u> ΔT _J	Breakdown Voltage Temperature Coefficient	$I_D = -250 \mu A$, Referenced to 25°C		-13		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -16 \text{ V}, \qquad V_{GS} = 0 \text{ V}$			-1	μΑ
I _{GSSF}	Gate-Body Forward Leakage	$V_{GS} = -12 \text{ V}, \qquad V_{DS} = 0 \text{ V}$			-100	nA
I _{GSSR}	Gate-Body Reverse Leakage	$V_{GS} = 12 \text{ V}, \qquad V_{DS} = 0 \text{ V}$			100	nA
On Char	acteristics (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = -250 \mu A$	-0.6	-0.9	-1.5	V
$\Delta V_{GS(th)} \over \Delta T_J$	Gate Threshold Voltage Temperature Coefficient	$I_D = -250 \mu A$, Referenced to 25°C		3.3		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	$\begin{array}{c} V_{GS} = -4.5 \ V, & I_D = -13 \ A \\ V_{GS} = -2.5 \ V, & I_D = -10.5 \ A \\ V_{GS} = -4.5 \ V, I_D = -13 \ A, \ T_J = 125 ^{\circ} C \end{array}$		7 10 9	9.5 14.5 13	mΩ
I _{D(on)}	On-State Drain Current	$V_{GS} = -4.5 \text{ V}, \qquad V_{DS} = -5 \text{ V}$	-60			Α
g FS	Forward Transconductance	$V_{DS} = -5 \text{ V}, \qquad I_{D} = -13 \text{ A}$		58		S
Dynamic	Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = -10 \text{ V}, \qquad V_{GS} = 0 \text{ V},$		4280		pF
C _{oss}	Output Capacitance	f = 1.0 MHz		873		pF
C _{rss}	Reverse Transfer Capacitance			400		pF
Switchir	ng Characteristics (Note 2)					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = -10 \text{ V}, \qquad I_{D} = -1 \text{ A},$		17	31	ns
t _r	Turn-On Rise Time	$V_{GS} = -4.5 \text{ V}, R_{GEN} = 6 \Omega$		11	20	ns
$t_{d(off)}$	Turn-Off Delay Time			115	184	ns
t _f	Turn-Off Fall Time			60	96	ns
Q_g	Total Gate Charge	$V_{DS} = -10 \text{ V}, \qquad I_{D} = -13 \text{ A},$		38	53	nC
Q_{gs}	Gate-Source Charge	$V_{GS} = -4.5 \text{ V}$		7		nC
Q_{gd}	Gate-Drain Charge			10		nC
Drain-S	ource Diode Characteristics	and Maximum Ratings				
Is	Maximum Continuous Drain-Sourc	e Diode Forward Current			-1.8	Α
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = -1.8 \text{ A} \text{(Note 2)}$		-0.7	-1.2	V
t _{rr}	Diode Reverse Recovery Time	$I_F = -13A$,		34		nS
Q _{rr}	Diode Reverse Recovery Charge	$d_{iF}/d_{t} = 100 \text{ A/}\mu\text{s}$		38		nC

Notes:

1. R_{BJA} is determined with the device mounted on a 1 in² 2 oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. The thermal resistance from the junction to the circuit board side of the solder ball, R_{BJB}, is defined for reference. For R_{BJC}, the thermal reference point for the case is defined as the top surface of the copper chip carrier. R_{BJC} and R_{BJB} are guaranteed by design while R_{BJA} is determined by the user's board design.



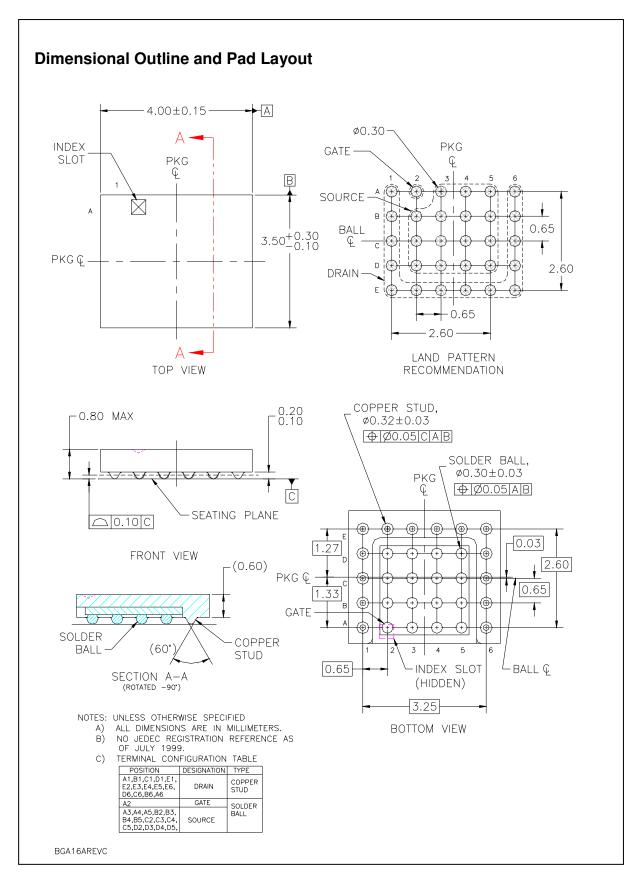
a) 56 °C/W when mounted on a 1in² pad of 2 oz copper



b) 119 °C/W when mounted on a minimum pad of 2 oz

Scale 1:1 on letter size paper

2. Pulse Test: Pulse Width < 300 $\mu s, \, Duty \, Cycle < 2.0\%$



Typical Characteristics

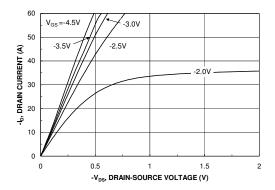


Figure 1. On-Region Characteristics.

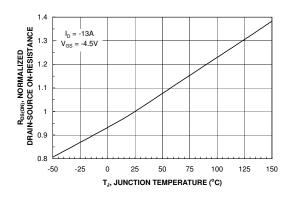


Figure 3. On-Resistance Variation with Temperature.

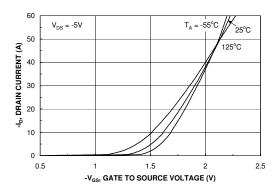


Figure 5. Transfer Characteristics.

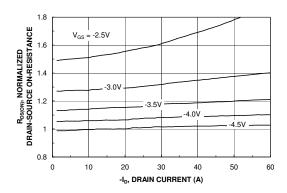


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

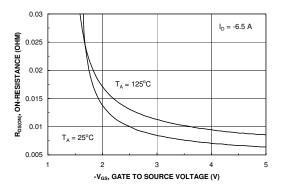


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

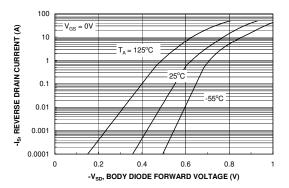
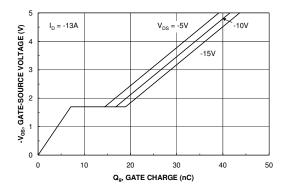


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



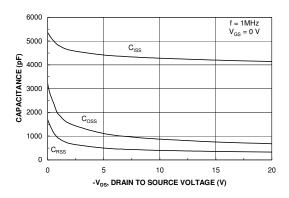
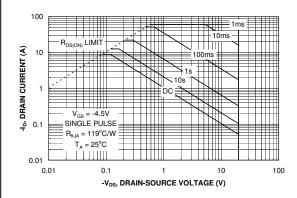


Figure 7. Gate Charge Characteristics.





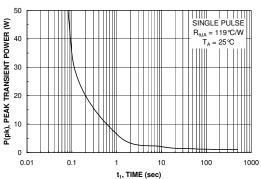


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

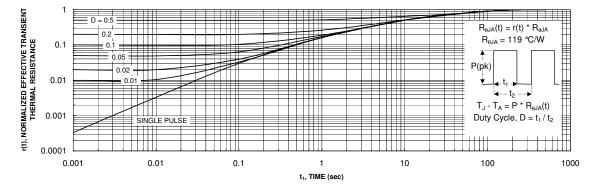


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

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